

<b>Notice of References Cited</b>	Application/Control No. 10/549,584		Applicant(s)/Patent Under Reexamination UCHIDA, HIDEKI	
	Examiner WEN-YING PATTY CHEN		Art Unit 2871	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0039224	04-2002	Johnson et al.	359/245
*	B	US-2004/0155999	08-2004	Okumura et al.	349/114
	C	US-			
	D	US-			
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	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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